

High Power NPN Silicon Power Transistors

... designed for linear amplifiers, series pass regulators, and inductive switching applications.

• Forward Biased Second Breakdown Current Capability

$$I_{S/b} = 3.75 \text{ Adc } @ V_{CE} = 40 \text{ Vdc} -- 2N3771$$

= 2.5 Adc @ $V_{CE} = 60 \text{ Vdc} -- 2N3772$

*MAXIMUM RATINGS

Rating	Symbol	2N3771	2N3772	Unit
Collector–Emitter Voltage	V _{CEO}	40	60	Vdc
Collector–Emitter Voltage	V _{CEX}	50	80	Vdc
Collector–Base Voltage	V _{CB}	50	100	Vdc
Emitter-Base Voltage	V _{EB}	5.0	7.0	Vdc
Collector Current — Continuous Peak	Ic	30 30	20 30	Adc
Base Current — Continuous Peak	I _B	7.5 15	5.0 15	Adc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	150 0.855		Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +200		°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	2N3771, 2N3772	Unit
Thermal Resistance, Junction to Case	θ_{JC}	1.17	°C/W

^{*}Indicates JEDEC Registered Data.

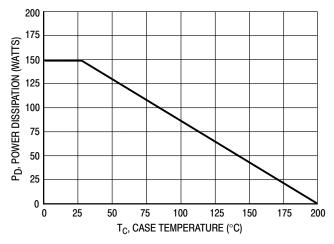


Figure 1. Power Derating

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

2N3771* 2N3772

*ON Semiconductor Preferred Device

20 and 30 AMPERE POWER TRANSISTORS NPN SILICON 40 and 60 VOLTS 150 WATTS



CASE 1-07 TO-204AA (TO-3)

ELECTRICAL CHARACTERISTICS ($T_C = 25$ °C unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS					
*Collector–Emitter Sustaining Voltage (1) $(I_C = 0.2 \text{ Adc}, I_B = 0)$	2N3771 2N3772	V _{CEO(sus)}	40 60	_	Vdc
Collector–Emitter Sustaining Voltage (I _C = 0.2 Adc, V _{EB(off)} = 1.5 Vdc, R _{BE} = 100 Ohms)	2N3771 2N3772	V _{CEX(sus)}	50 80	_	Vdc
Collector–Emitter Sustaining Voltage (I _C = 0.2 Adc, R _{BE} = 100 Ohms)	2N3771 2N3772	V _{CER(sus)}	45 70	_	Vdc
*Collector Cutoff Current $(V_{CE} = 30 \text{ Vdc}, I_B = 0)$ $(V_{CE} = 50 \text{ Vdc}, I_B = 0)$ $(V_{CE} = 25 \text{ Vdc}, I_B = 0)$	2N3771 2N3772	I _{CEO}	_ _	10 10	mAdc
*Collector Cutoff Current $(V_{CE} = 50 \text{ Vdc}, V_{EB(off)} = 1.5 \text{ Vdc})$ $(V_{CE} = 100 \text{ Vdc}, V_{EB(off)} = 1.5 \text{ Vdc})$ $(V_{CE} = 45 \text{ Vdc}, V_{EB(off)} = 1.5 \text{ Vdc})$ $(V_{CE} = 30 \text{ Vdc}, V_{EB(off)} = 1.5 \text{ Vdc}, T_{C} = 150^{\circ}\text{C})$ $(V_{CE} = 45 \text{ Vdc}, V_{EB(off)} = 1.5 \text{ Vdc}, T_{C} = 150^{\circ}\text{C})$	2N3771 2N3772 2N6257 2N3771 2N3772	I _{CEV}	_ _ _ _ _	2.0 5.0 4.0 10	mAdc
*Collector Cutoff Current $(V_{CB} = 50 \text{ Vdc}, I_E = 0)$ $(V_{CB} = 100 \text{ Vdc}, I_E = 0)$	2N3771 2N3772	I _{CBO}	_ _	2.0 5.0	mAdc
*Emitter Cutoff Current $(V_{BE} = 5.0 \text{ Vdc}, I_{C} = 0)$ $(V_{BE} = 7.0 \text{ Vdc}, I_{C} = 0)$	2N3771 2N3772	I _{EBO}	_ _	5.0 5.0	mAdc
ON CHARACTERISTICS			Г	1	T
DC Current Gain (1) ($I_C = 15 \text{ Adc}$, $V_{CE} = 4.0 \text{ Vdc}$) ($I_C = 10 \text{ Adc}$, $V_{CE} = 4.0 \text{ Vdc}$) ($I_C = 8.0 \text{ Adc}$, $V_{CE} = 4.0 \text{ Vdc}$) ($I_C = 30 \text{ Adc}$, $V_{CE} = 4.0 \text{ Vdc}$)	2N3771 2N3772 2N3771 2N3772	h _{FE}	15 15 5.0	60 60 —	_
$(I_C = 20 \text{ Adc, } V_{CE} = 4.0 \text{ Vdc})$ $Collector-Emitter Saturation Voltage$ $(I_C = 15 \text{ Adc, } I_B = 1.5 \text{ Adc})$ $(I_C = 10 \text{ Adc, } I_B = 1.0 \text{ Adc})$ $(I_C = 30 \text{ Adc, } I_B = 6.0 \text{ Adc})$ $(I_C = 20 \text{ Adc, } I_B = 4.0 \text{ Adc})$	2N3771 2N3772 2N3771 2N3772	V _{CE} (sat)	5.0 — — — —	2.0 1.4 4.0 4.0	Vdc
Base–Emitter On Voltage (I_C = 15 Adc, V_{CE} = 4.0 Vdc) (I_C = 10 Adc, V_{CE} = 4.0 Vdc) (I_C = 8.0 Adc, V_{CE} = 4.0 Vdc)	2N3771 2N3772	V _{BE(on)}	_ _	2.7 2.2	Vdc
*DYNAMIC CHARACTERISTICS					
Current–Gain — Bandwidth Product ($I_C = 1.0 \text{ Adc}$, $V_{CE} = 4.0 \text{ Vdc}$, $f_{test} = 50 \text{ kHz}$)		f _T	0.2	_	MHz
Small–Signal Current Gain ($I_C = 1.0 \text{ Adc}$, $V_{CE} = 4.0 \text{ Vdc}$, $f = 1.0 \text{ kHz}$)		h _{fe}	40	_	_
SECOND BREAKDOWN					
Second Breakdown Energy with Base Forward Biased, $t = 1.0 \text{ s}$ (r ($V_{CE} = 40 \text{ Vdc}$) ($V_{CE} = 60 \text{ Vdc}$)	non–repetitive) 2N3771 2N3772	I _{S/b}	3.75 2.5	_	Adc

^{*}Indicates JEDEC Registered Data. (1) Pulse Test: 300 µs, Rep. Rate 60 cps.

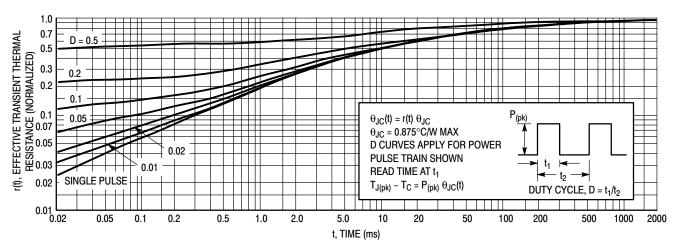


Figure 2. Thermal Response — 2N3771, 2N3772

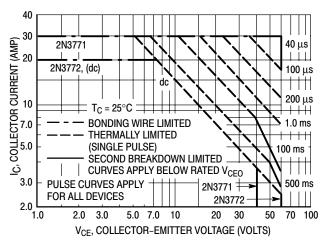
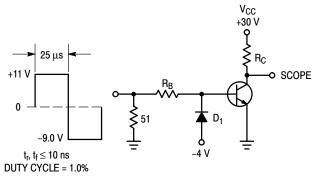


Figure 3. Active–Region Safe Operating Area — 2N3771, 2N3772

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation: i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

Figure 3 is based on JEDEC registered Data. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)} < 200^{\circ}\text{C}$. $T_{J(pk)}$ may be calculated from the data of Figure 2. Using data of Figure 2 and the pulse power limits of Figure 3, $T_{J(pk)}$ will be found to be less than $T_{J(max)}$ for pulse widths of 1 ms and less. When using ON Semiconductor transistors, it is permissible to increase the pulse power limits until limited by $T_{J(max)}$.



RB AND RC ARE VARIED TO OBTAIN DESIRED CURRENT LEVELS

D1 MUST BE FAST RECOVERY TYPE, e.g.: 1N5825 USED ABOVE I_B \approx 100 mA MSD6100 USED BELOW I_B \approx 100 mA

Figure 4. Switching Time Test Circuit

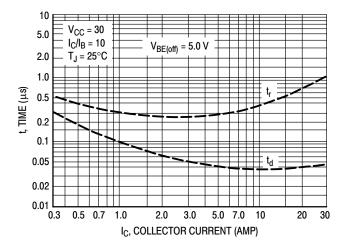
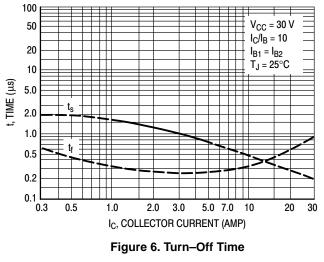


Figure 5. Turn-On Time



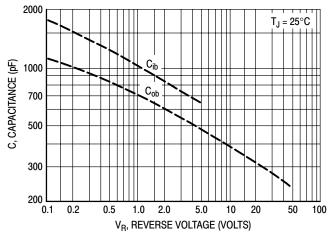
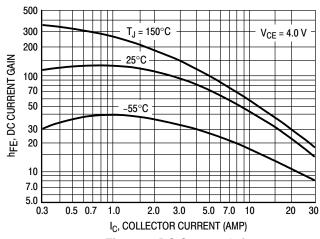
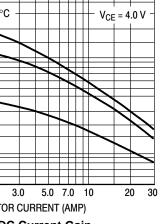


Figure 7. Capacitance





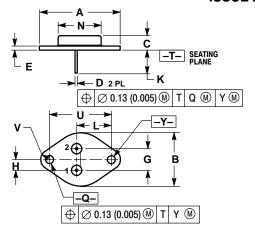
2.0 V_{CE}, COLLECTOR-EMITTER VOLTAGE (VOLTS) $T_J = 25^{\circ}C$ 1.6 10 A 20 A $I_C = 2.0 A$ 5.0 A 1.2 8.0 0.4 0.01 2.0 0.02 0.05 0.1 0.2 0.5 1.0 5.0 10 I_C , COLLECTOR CURRENT (AMP)

Figure 8. DC Current Gain

Figure 9. Collector Saturation Region

PACKAGE DIMENSIONS

CASE 1-07 TO-204AA (TO-3) **ISSUE** Z



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	1.550 REF		39.37 REF		
В		1.050		26.67	
С	0.250	0.335	6.35	8.51	
D	0.038	0.043	0.97	1.09	
Е	0.055	0.070	1.40	1.77	
G	0.430 BSC		10.92 BSC		
Н	0.215 BSC		5.46 BSC		
K	0.440	0.480	11.18	12.19	
L	0.665 BSC		16.89 BSC		
N		0.830		21.08	
Q	0.151	0.165	3.84	4.19	
U	1.187 BSC		30.15 BSC		
٧	0.131	0.188	3.33	4.77	

STYLE 1: PIN 1. BASE 2. EMITTER CASE: COLLECTOR





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